Drexel University Materials Characterization Core Facility

RRID:SCR_022684
Type: Tool

Proper Citation

Drexel University Materials Characterization Core Facility (RRID:SCR_022684)

Resource Information

**URL:** [https://drexel.edu/core-facilities/facilities/material-characterization/](https://drexel.edu/core-facilities/facilities/material-characterization/)

**Proper Citation:** Drexel University Materials Characterization Core Facility (RRID:SCR_022684)

**Description:** Facility provides technical expertise and instrumentation including nanoscience and engineering, polymer research, biomedical engineering, and chemistry and physics of solid materials. Houses electron microscopes, X-ray diffractometers, X-ray photoelectron spectrometer and suite of sample preparation tools. Staff members provide expert consultation, training and assistance to MCC users. Core is involved in teaching both undergraduate and graduate level courses in Materials Science and Engineering, Mechanical Engineering and Mechanics, Biomedical Engineering, and Biology. Trained and certified users are welcome to work independently on our instruments.

**Abbreviations:** MCC

**Synonyms:** Materials Characterization Core, Drexel University Materials Characterization Core

**Resource Type:** access service resource, core facility, service resource

**Keywords:** USEDit, ABRF, nanoscience and engineering, polymer research, biomedical engineering, chemistry and physics of solid materials

**Availability:** open

**Resource Name:** Drexel University Materials Characterization Core Facility
**Resource ID:** SCR_022684

**Alternate IDs:** ABRF_1502

**Alternate URLs:** https://coremarketplace.org/?FacilityID=1502&citation=1

---

**Ratings and Alerts**

No rating or validation information has been found for Drexel University Materials Characterization Core Facility.

No alerts have been found for Drexel University Materials Characterization Core Facility.

---

**Data and Source Information**

**Source:** SciCrunch Registry

---

**Usage and Citation Metrics**

We have not found any literature mentions for this resource.